

# ***IRFR320, IRFR321, IRFR322, IRFU320, IRFU321, IRFU322***

**2.6A and 3.1A, 350V and 400V, 1.8 and 2.5 Ohm,  
N-Channel Power MOSFETs**

January 1998

## **Features**

- 2.6A and 3.1A, 350V and 400V
- $r_{DS(ON)} = 1.8\Omega$  and  $2.5\Omega$
- Single Pulse Avalanche Energy Rated
- SOA is Power Dissipation Limited
- Nanosecond Switching Speeds
- Linear Transfer Characteristics
- High Input Impedance
- Related Literature
  - TB334 "Guidelines for Soldering Surface Mount Components to PC Boards"

## **Ordering Information**

PART NUMBER	PACKAGE	BRAND
IRFR320	TO-252AA	IFR320
IRFR321	TO-252AA	IFR321
IRFR322	TO-252AA	IFR322
IRFU320	TO-251AA	IFU320
IRFU321	TO-251AA	IFU321
IRFU322	TO-251AA	IFU322

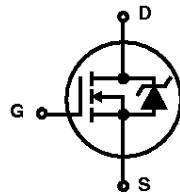
NOTE: When ordering, use the entire part number.

## **Description**

These are N-Channel enhancement mode silicon gate power field effect transistors. They are advanced power MOSFETs designed, tested, and guaranteed to withstand a specified level of energy in the breakdown avalanche mode of operation. All of these power MOSFETs are designed for applications such as switching regulators, switching converters, motor drivers, relay drivers, and drivers for high power bipolar switching transistors requiring high speed and low gate drive power. These types can be operated directly from integrated circuits.

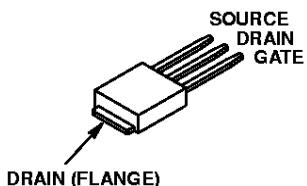
Formerly developmental type TA17404.

## **Symbol**

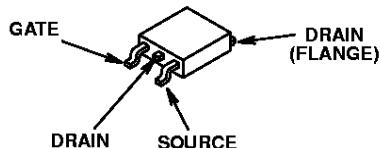


## **Packaging**

JEDEC TO-251AA



JEDEC TO-252AA



# IRFR320, IRFR321, IRFR322, IRFU320, IRFU321, IRFU322

## Absolute Maximum Ratings $T_C = 25^\circ\text{C}$ , Unless Otherwise Specified

	IRFR320 IRFU320	IRFR321 IRFU321	IRFR322 IRFU322	UNITS	
Drain to Source Voltage (Note 1) . . . . .	$V_{DS}$	400	350	400	V
Drain to Gate Voltage ( $R_{GS} = 20\text{k}\Omega$ ) (Note 1) . . . . .	$V_{DGR}$	400	350	400	V
Continuous Drain Current. . . . .	$I_D$	3.1	3.1	2.6	A
$T_C = 100^\circ\text{C}$ . . . . .	$I_D$	2.0	2.0	1.7	A
Pulsed Drain Current (Note 3) . . . . .	$I_{DM}$	12	12	10	A
Gate to Source Voltage . . . . .	$V_{GS}$	$\pm 20$	$\pm 20$	$\pm 20$	V
Maximum Power Dissipation . . . . .	$P_D$	50	50	50	W
Linear Derating Factor . . . . .		0.4	0.4	0.4	W/ $^\circ\text{C}$
Single Pulse Avalanche Energy Rating (Note 4) . . . . .	$E_{AS}$	190	190	190	mJ
Operating and Storage Temperature . . . . .	$T_J, T_{STG}$	-55 to 150	-55 to 150	-55 to 150	$^\circ\text{C}$
Maximum Temperature for Soldering					
Leads at 0.063in (1.6mm) from Case for 10s . . . . .	$T_L$	300	300	300	$^\circ\text{C}$
Package Body for 10s, See Techbrief 334 . . . . .	$T_{pkg}$	260	260	260	$^\circ\text{C}$

**CAUTION:** Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

## NOTE:

1.  $T_J = 25^\circ\text{C}$  to  $125^\circ\text{C}$ .

## Electrical Specifications $T_C = 25^\circ\text{C}$ , Unless Otherwise Specified

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Drain to Source Breakdown Voltage IRFR320, IRFR322, IRFU320, IRFU322	$BV_{DSS}$	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$ , (Figure 10)				
IRFR321, IRFU321			400	-	-	V
Gate Threshold Voltage	$V_{GS(\text{TH})}$	$V_{GS} = V_{DS}, I_D = 250\mu\text{A}$	2.0	-	4.0	V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = \text{Rated } BV_{DSS}, V_{GS} = 0\text{V}$	-	-	25	$\mu\text{A}$
		$V_{DS} = 0.8 \times \text{Rated } BV_{DSS}, V_{GS} = 0\text{V}, T_J = 125^\circ\text{C}$	-	-	250	$\mu\text{A}$
On-State Drain Current (Note 2) IRFR320, IRFR321, IRFU320, IRFU321	$I_{D(\text{ON})}$	$V_{DS} > I_{D(\text{ON})} \times r_{DS(\text{ON})\text{MAX}}, V_{GS} = 10\text{V}$ , (Figure 7)				
IRFR322, IRFU322			3.1	-	-	A
Gate to Source Leakage Current	$I_{GSS}$	$V_{GS} = \pm 20\text{V}$	-	-	$\pm 100$	nA
Drain to Source On Resistance (Note 2) IRFR320, IRFR321, IRFU320, IRFU321	$r_{DS(\text{ON})}$	$I_D = 1.7\text{A}, V_{GS} = 10\text{V}$ , (Figures 8, 9)				
IRFR322, IRFU322			-	1.6	1.8	$\Omega$
-			-	1.6	2.5	$\Omega$
Forward Transconductance (Note 2)	$g_{fs}$	$V_{DS} \geq 50\text{V}, I_D = 1.7\text{A}$ , (Figure 12)	1.7	2.6	-	S
Turn-On Delay Time	$t_{d(\text{ON})}$	$V_{DD} = 200\text{V}, I_D \approx 3.1\text{A}, R_G = 18\Omega, R_L = 63\Omega$ , $V_{GS} = 10\text{V}$ , (Figures 16, 17) MOSFET Switching Times are Essentially Independent of Operating Temperature	-	10	15	ns
Rise Time	$t_r$		-	14	21	ns
Turn-Off Delay Time	$t_{d(\text{OFF})}$		-	30	45	ns
Fall Time	$t_f$		-	13	20	ns
Total Gate Charge (Gate to Source + Gate to Drain)	$Q_g(\text{TOT})$		-	13	20	nC
Gate to Source Charge	$Q_{gs}$	$V_{GS} = 10\text{V}, I_D = 3.1\text{A}, V_{DS} = 0.8 \times \text{Rated } BV_{DSS}$ $I_{G(\text{REF})} = 1.5\text{mA}$ , (Figures 14, 19, 20) Gate Charge is Essentially Independent of Operating Temperature	-	2.2	3.3	nC
Gate to Drain "Miller" Charge	$Q_{gd}$		-	7.2	11	nC

**Electrical Specifications**  $T_C = 25^\circ\text{C}$ , Unless Otherwise Specified (Continued)

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNITS	
Input Capacitance	$C_{ISS}$	$V_{DS} = 25\text{V}$ , $V_{GS} = 0\text{V}$ , $f = 1\text{MHz}$ , (Figure 11)		-	350	-	pF	
Output Capacitance	$C_{OSS}$			-	64	-	pF	
Reverse Transfer Capacitance	$C_{RSS}$			-	8.1	-	pF	
Internal Drain Inductance	$L_D$	Measured from the Drain Lead, 6.0mm (0.25in) from Package to Center of Die	Modified MOSFET Symbol Showing the Internal Device Inductances	-	4.5	-	nH	
Internal Source Inductance	$L_S$	Measured from the Source Lead, 6.0mm (0.25in) from Package to Source Bonding Pad		-	7.5	-	nH	
Thermal Resistance, Junction to Case	$R_{\theta JC}$				-	-	$^\circ\text{C/W}$	
Thermal Resistance, Junction to Ambient	$R_{\theta JA}$	Typical Solder Mount			-	-	$^\circ\text{C/W}$	

**Source to Drain Diode Specifications**

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNITS
Continuous Source to Drain Current	$I_{SD}$	Modified MOSFET Symbol Showing the Integral Reverse P-N Junction Rectifier		-	-	3.1	A
Pulse Source to Drain Current (Note 3)	$I_{SDM}$			-	-	12	A
Source to Drain Diode Voltage (Note 2)	$V_{SD}$	$T_J = 25^\circ\text{C}$ , $I_{SD} = 3.1\text{A}$ , $V_{GS} = 0\text{V}$ , (Figure 13)		-	-	1.6	V
Reverse Recovery Time	$t_{rr}$	$T_J = 25^\circ\text{C}$ , $I_{SD} = 3.1\text{A}$ , $dI_{SD}/dt = 100\text{A}/\mu\text{s}$		120	270	600	ns
Reverse Recovery Charge	$Q_{RR}$	$T_J = 25^\circ\text{C}$ , $I_{SD} = 3.1\text{A}$ , $dI_{SD}/dt = 100\text{A}/\mu\text{s}$		0.64	1.4	3.0	$\mu\text{C}$

NOTES:

2. Pulse test: pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$ .
3. Repetitive rating: pulse width limited by maximum junction temperature. See Transient Thermal Impedance curve (Figure 3).
4.  $V_{DD} = 50\text{V}$ , starting  $T_J = 25^\circ\text{C}$ ,  $L = 3.1\text{mH}$ ,  $R_{GS} = 25\Omega$ , peak  $I_{AS} = 3.1\text{A}$ .

**Typical Performance Curves** Unless Otherwise Specified

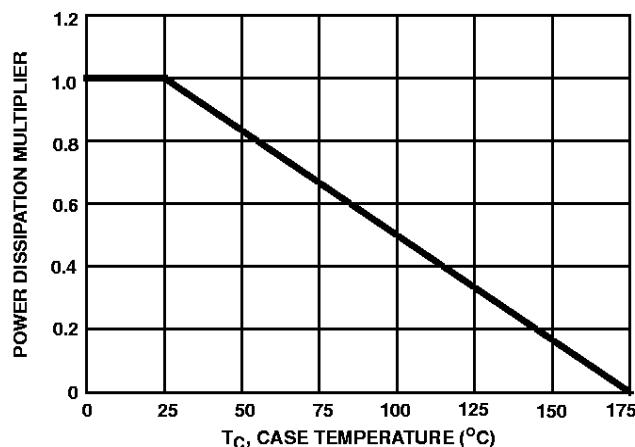


FIGURE 1. NORMALIZED POWER DISSIPATION vs CASE TEMPERATURE

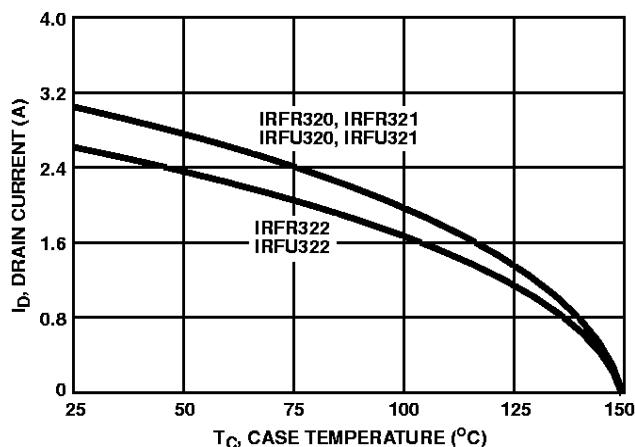


FIGURE 2. MAXIMUM CONTINUOUS DRAIN CURRENT vs CASE TEMPERATURE

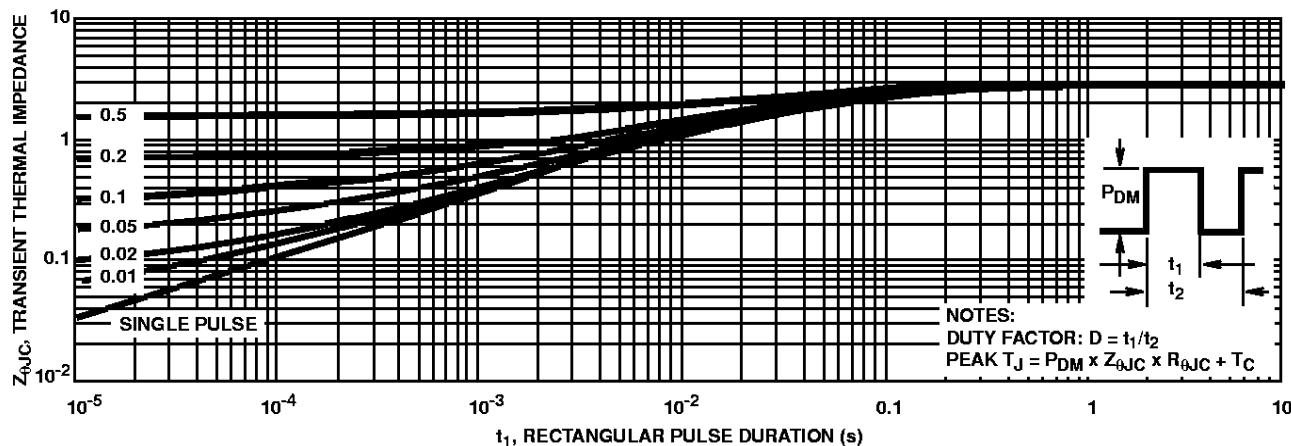


FIGURE 3. MAXIMUM TRANSIENT THERMAL IMPEDANCE

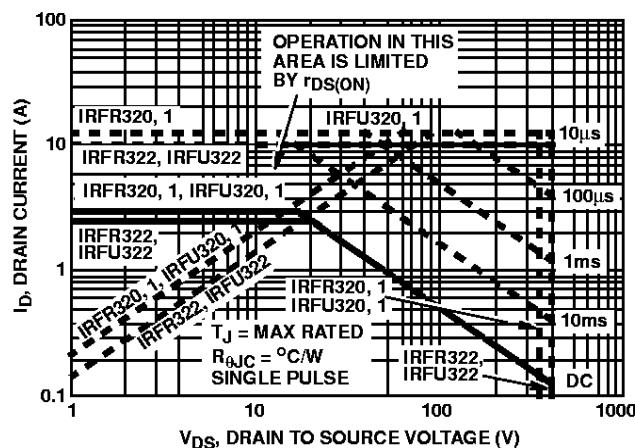


FIGURE 4. FORWARD BIAS SAFE OPERATING AREA

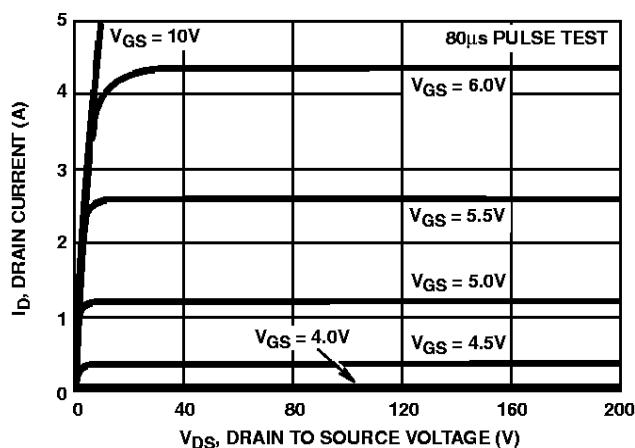


FIGURE 5. OUTPUT CHARACTERISTICS

**Typical Performance Curves** Unless Otherwise Specified (Continued)

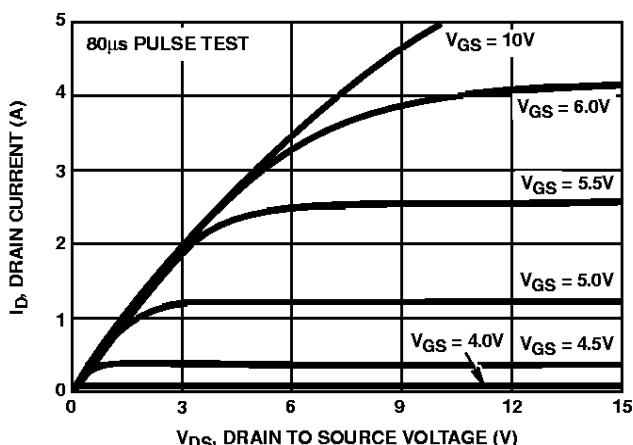


FIGURE 6. SATURATION CHARACTERISTICS

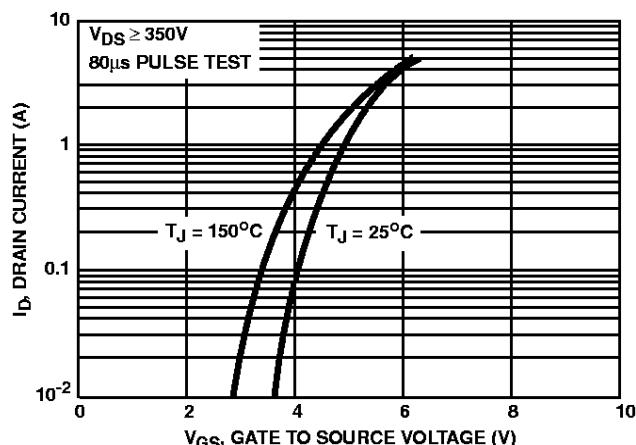


FIGURE 7. TRANSFER CHARACTERISTICS

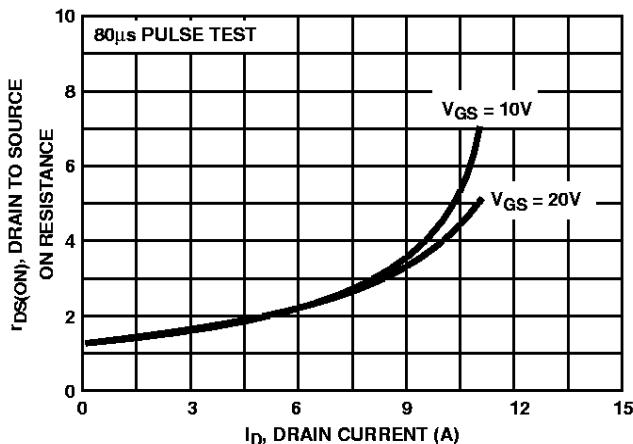


FIGURE 8. DRAIN TO SOURCE ON RESISTANCE vs GATE VOLTAGE AND DRAIN CURRENT

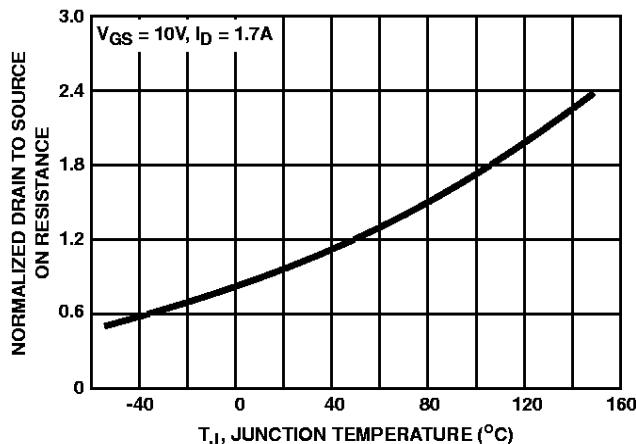


FIGURE 9. NORMALIZED DRAIN TO SOURCE ON RESISTANCE vs JUNCTION TEMPERATURE

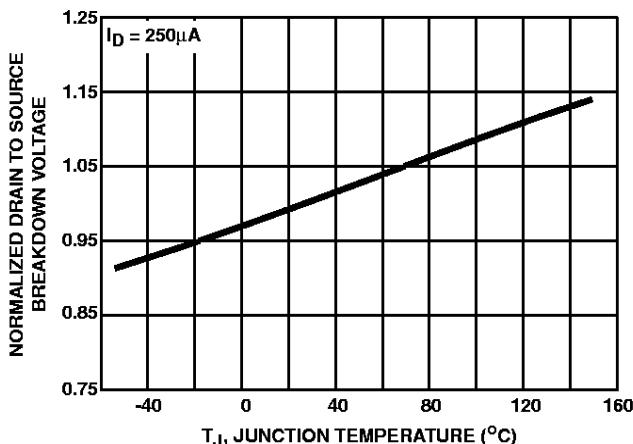


FIGURE 10. NORMALIZED DRAIN TO SOURCE BREAKDOWN VOLTAGE vs JUNCTION TEMPERATURE

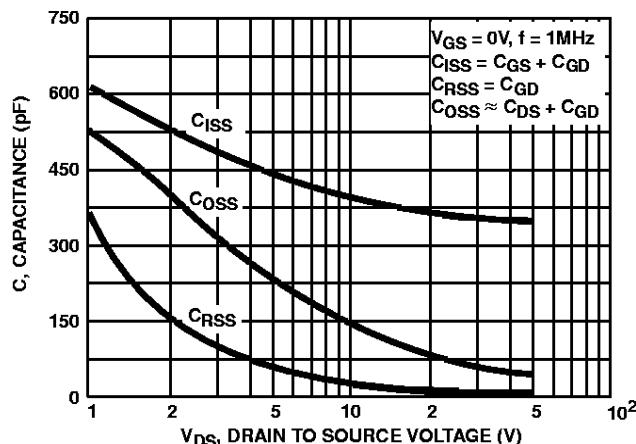


FIGURE 11. CAPACITANCE vs DRAIN TO SOURCE VOLTAGE

**Typical Performance Curves** Unless Otherwise Specified (Continued)

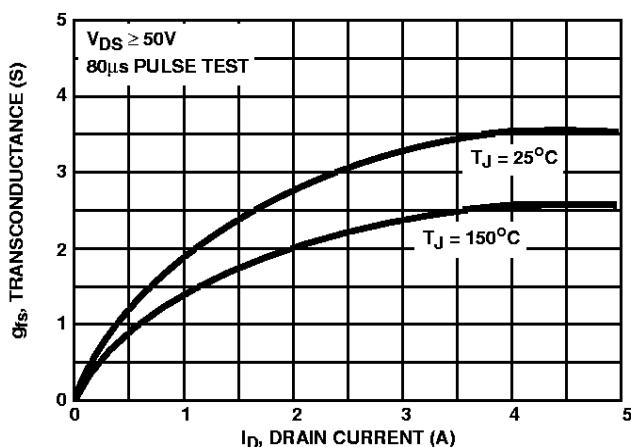


FIGURE 12. TRANSCONDUCTANCE vs DRAIN CURRENT

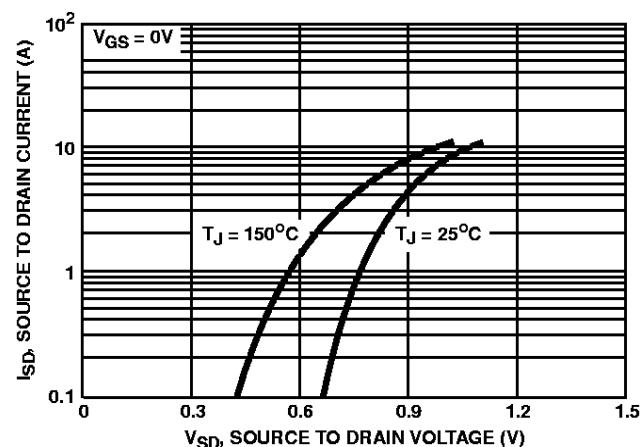


FIGURE 13. SOURCE TO DRAIN DIODE VOLTAGE

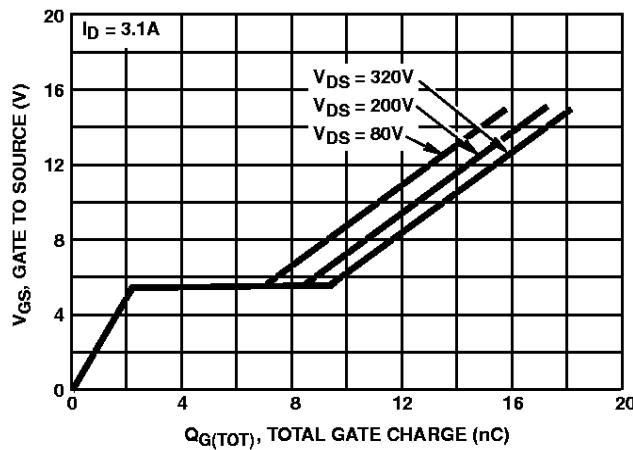


FIGURE 14. GATE TO SOURCE VOLTAGE vs GATE CHARGE

### *Test Circuits and Waveforms*

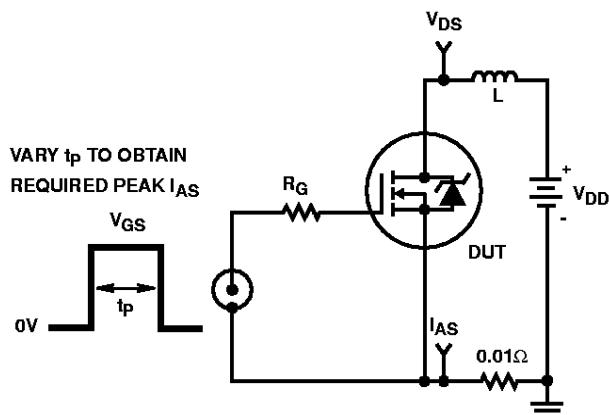


FIGURE 15. UNCLAMPED ENERGY TEST CIRCUIT

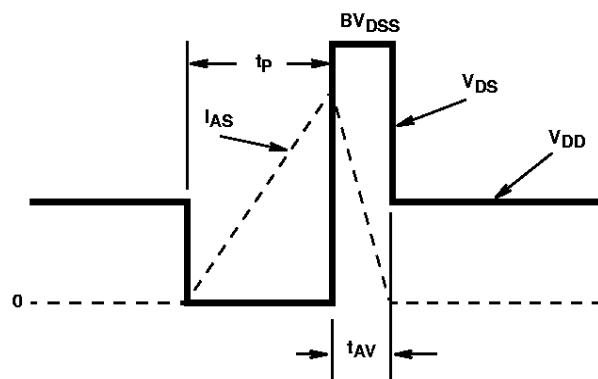


FIGURE 16. UNCLAMPED ENERGY WAVEFORMS

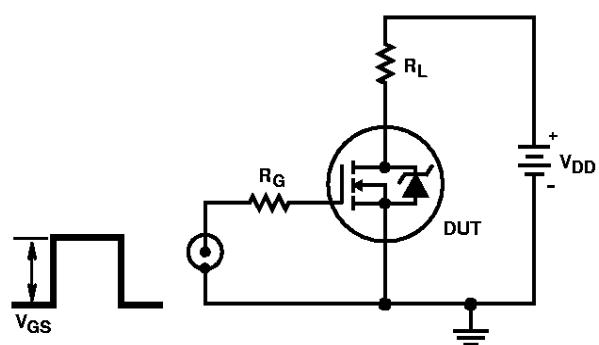


FIGURE 17. SWITCHING TIME TEST CIRCUIT

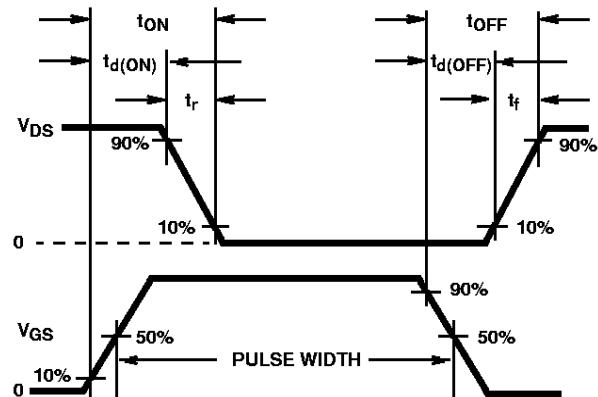


FIGURE 18. RESISTIVE SWITCHING WAVEFORMS

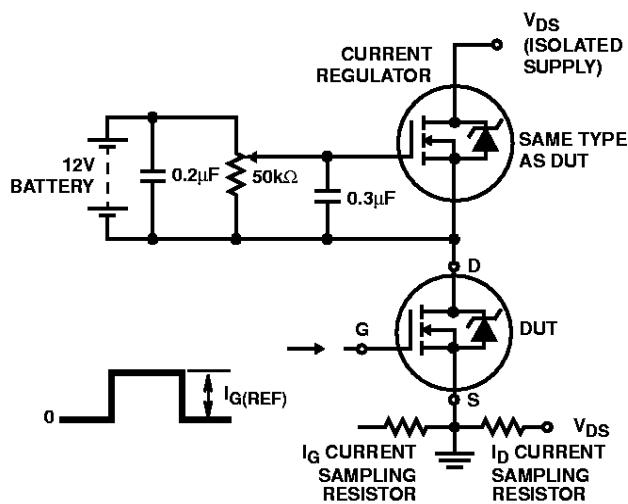


FIGURE 19. GATE CHARGE TEST CIRCUIT

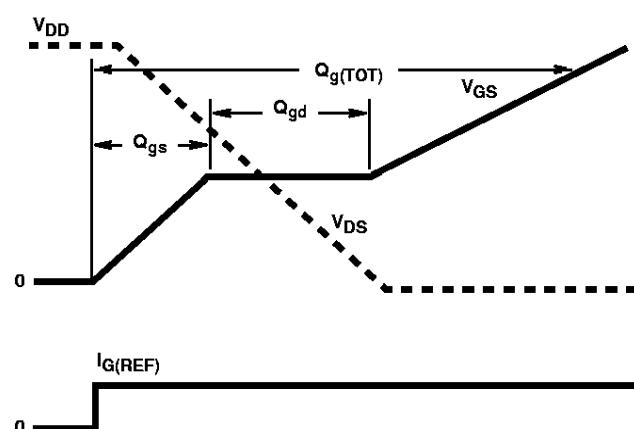


FIGURE 20. GATE CHARGE WAVEFORMS